MOSFET - Power, Single, N-Channel, SO-8 FL 30 V, 93 A

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

• CPU Power Delivery, DC-DC Converters

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

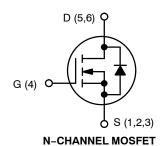
| Parameter | | | Symbol | Value | Unit |
|----------------------------------------------------|---------------------------------------|------------------------|--------------------------------------|----------------|------|
| Drain-to-Source Voltage | | | V_{DSS} | 30 | V |
| Gate-to-Source Vol | -Source Voltage | | | ±20 | V |
| Continuous Drain Current R _{0JA} | | T _A = 25°C | I _D | 21.8 | Α |
| (Note 1) | | T _A = 100°C | | 13.8 | |
| Power Dissipation R _{θJA} (Note 1) | | T _A = 25°C | P _D | 2.63 | W |
| Continuous Drain Current R _{θJA} ≤ | | T _A = 25°C | I _D | 40 | Α |
| 10 s (Note 1) | | T _A = 100°C | | 25 | |
| Power Dissipation $R_{\theta,IA} \le 10 \text{ s}$ | | T _A = 25°C | P _D | 8.7 | W |
| (Note 1) | Steady | | | | |
| Continuous Drain Current R _{0JA} | State | T _A = 25°C | I _D | 13 | Α |
| (Note 2) | | T _A = 100°C | | 8.2 | |
| Power Dissipation R _{0JA} (Note 2) | | T _A = 25°C | P _D | 0.93 | W |
| Continuous Drain Current R _{θJC} | | T _C = 25°C | I _D | 93 | Α |
| (Note 1) | | T _C = 85°C | | 59 | |
| Power Dissipation $R_{\theta JC}$ (Note 1) | | T _C = 25°C | P _D | 48 | W |
| Pulsed Drain Current | $T_A = 25^{\circ}C, t_p = 10 \ \mu s$ | | I _{DM} | 275 | Α |
| Current Limited by Package T _A = 25°C | | I _{Dmax} | 100 | Α | |
| Operating Junction and Storage Temperature | | | T _J , T _{STG} | –55 to +150 | °C |
| Source Current (Body Diode) | | | I _S | 44 | Α |
| Drain to Source DV/DT | | | dV/d _t | 6 | V/ns |



ON Semiconductor®

http://onsemi.com

| V _{(BR)DSS} | R _{DS(ON)} MAX | I _D MAX |
|----------------------|-------------------------|--------------------|
| 30 V | 3.2 mΩ @ 10 V | 00.4 |
| 30 V | 4.2 mΩ @ 4.5 V | 93 A |





MARKING DIAGRAM 4935N **AYWZZ** D

= Assembly Location Α

= Year W = Work Week ZZ = Lot Traceability

ORDERING INFORMATION

| Device | Package | Shipping [†] |
|----------------|-----------|-----------------------|
| NTMFS4935NT1G | SO-8 FL | 1500 / |
| NTMFS4935NCT1G | (Pb-Free) | Tape & Reel |
| NTMFS4935NT3G | SO-8 FL | 5000 / |
| NTMFS4935NCT3G | (Pb-Free) | Tape & Reel |

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise stated)

| Parameter | Symbol | Value | Unit |
|-------------------------------------------------------------------------------------------------------------------------------------------------------|-----------------|-------|------|
| Single Pulse Drain-to-Source Avalanche Energy T_J = 25°C, V_{DD} = 24 V, V_{GS} = 10 V, I_L = 47 A_{pk} , L = 0.1 mH, R_G = 25 Ω | E _{AS} | 110 | mJ |
| Lead Temperature for Soldering Purposes (1/8" from case for 10 s) | T _L | 260 | °C |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surface—mounted on FR4 board using 1 sq-in pad, 1 oz Cu.

2. Surface—mounted on FR4 board using the minimum recommended pad size.

THERMAL RESISTANCE MAXIMUM RATINGS

| Parameter | Symbol | Value | Unit |
|---------------------------------------------|-----------------|-------|-------|
| Junction-to-Case (Drain) | $R_{	heta JC}$ | 2.6 | |
| Junction-to-Ambient - Steady State (Note 3) | $R_{	heta JA}$ | 47.5 | °C/W |
| Junction-to-Ambient - Steady State (Note 4) | $R_{\theta JA}$ | 134.8 | *C/VV |
| Junction-to-Ambient – (t ≤ 10 s) (Note 3) | $R_{	heta JA}$ | 14.4 | |

- Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

ELECTRICAL CHARACTERISTICS (T.1 = 25°C unless otherwise specified)

| Parameter | Symbol | Test Condition | | Min | Тур | Max | Unit |
|--------------------------------------------------------------|------------------------------------------|-------------------------------------------------------------------------------------|-----------------------------|-----|-------|-------|----------|
| OFF CHARACTERISTICS | | | | | 1 | | |
| Drain-to-Source Breakdown Voltage | V _{(BR)DSS} | V_{GS} = 0 V, I_D = 250 μA | | 30 | | | V |
| Drain-to-Source Breakdown Voltage (transient) | V _{(BR)DSSt} | V_{GS} = 0 V, $I_{D(aval)}$ = 19.5 A, T_{case} = 25°C, $t_{transient}$ = 100 ns | | 34 | | | V |
| Drain-to-Source Breakdown Voltage Temperature Coefficient | V _{(BR)DSS} / T _J | | | | 15 | | mV/°C |
| Zero Gate Voltage Drain Current | I _{DSS} | $V_{GS} = 0 V$ | T _J = 25°C | | | 1.0 | _ |
| | | V _{DS} = 24 V | T _J = 125°C | | | 10 | μΑ |
| Gate-to-Source Leakage Current | I _{GSS} | V _{DS} = 0 V, V _{GS} | s = ±20 V | | | ±100 | nA |
| ON CHARACTERISTICS (Note 5) | | | | | | | |
| Gate Threshold Voltage | V _{GS(TH)} | $V_{GS} = V_{DS}, I_D$ | = 250 μΑ | 1.2 | 1.63 | 2.2 | V |
| Negative Threshold Temperature Coefficient | V _{GS(TH)} /T _J | | | | 4.0 | | mV/°C |
| Drain-to-Source On Resistance | R _{DS(on)} | V _{GS} = 10 V | I _D = 30 A | | 2.7 | 3.2 | _ |
| | | | I _D = 15 A | | 2.7 | | |
| | | V _{GS} = 4.5 V | I _D = 30 A | | 3.7 | 4.2 | mΩ |
| | | | I _D = 15 A | | 3.7 | | |
| Forward Transconductance | 9FS | V _{DS} = 1.5 V, I _D = 15 A | | | 32 | | S |
| CHARGES, CAPACITANCES & GATE RESIS | TANCE | | | | • | | |
| Input Capacitance | C _{ISS} | | | | 3579 | 4850 | |
| Output Capacitance | C _{OSS} | V _{GS} = 0 V, f = 1 MHz, V _{DS} = 15 V | | | 1264 | 1710 | pF |
| Reverse Transfer Capacitance | C _{RSS} | | | | 39 | 59 | 1 |
| Capacitance Ratio | C _{RSS} / C _{ISS} | V _{GS} = 0 V, f = 1 MH | z, V _{DS} = 15 V | | 0.011 | 0.022 | |
| Total Gate Charge | Q _{G(TOT)} | | | | 22 | | |
| Threshold Gate Charge | Q _{G(TH)} | 45.4.7 | 45.771 00.4 | | 5.6 | | 1 |
| Gate-to-Source Charge | Q_{GS} | $V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}; I_D = 30 \text{ A}$ | | | 10.2 | | nC |
| Gate-to-Drain Charge | Q_{GD} | | | | 3.0 | | |
| Total Gate Charge | Q _{G(TOT)} | V _{GS} = 10 V, V _{DS} = 1 | 15 V; I _D = 30 A | | 49.4 | | nC |
| SWITCHING CHARACTERISTICS (Note 6) | | | | | | | |
| Turn-On Delay Time | t _{d(ON)} | | | | 16.3 | | |
| Rise Time | t _r | V_{GS} = 4.5 V, V_{DS} = 15 V, I_{D} = 15 A, R_{G} = 3.0 Ω | | | 20 | | 1 |
| Turn-Off Delay Time | t _{d(OFF)} | | | | 27.5 | | ns |
| Fall Time | t _f | | | | 6.6 | | 1 |

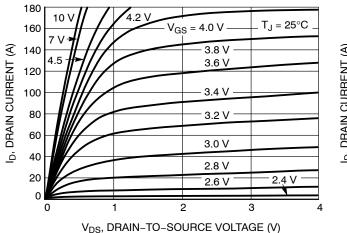
- 5. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.
 6. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

| Parameter | Symbol | Test Condition | | Min | Тур | Max | Unit |
|------------------------------|---------------------|------------------------------------------------------------------------------------|------------------------|-----|-------|-----|------|
| SWITCHING CHARACTERISTICS (N | ote 6) | | | • | • | | |
| Turn-On Delay Time | t _{d(ON)} | V_{GS} = 10 V, V_{DS} = 15 V, I_{D} = 15 A, R_{G} = 3.0 Ω | | | 11.2 | | - ns |
| Rise Time | t _r | | | | 18.7 | | |
| Turn-Off Delay Time | t _{d(OFF)} | | | | 28.3 | | |
| Fall Time | t _f | | | | 12.1 | | |
| DRAIN-SOURCE DIODE CHARACTE | ERISTICS | | | | | | |
| Forward Diode Voltage | V _{SD} | V _{GS} = 0 V, | T _J = 25°C | | 0.85 | 1.1 | .,, |
| | | $V_{GS} = 0 \text{ V},$ $I_{S} = 30 \text{ A}$ | T _J = 125°C | | 0.72 | | _ V |
| Reverse Recovery Time | t _{RR} | $V_{GS} = 0 \text{ V, dIS/dt} = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 30 \text{ A}$ | | | 44.4 | | ns |
| Charge Time | t _a | | | | 21.6 | | |
| Discharge Time | t _b | | | | 22.8 | | |
| Reverse Recovery Charge | Q _{RR} | | | | 45 | | nC |
| PACKAGE PARASITIC VALUES | | | | | | | |
| Source Inductance | L _S | | | | 0.65 | | nΗ |
| Drain Inductance | L _D | T _A = 25°C | | | 0.005 | | nΗ |
| Gate Inductance | L _G | | | | 1.84 | | nΗ |
| Gate Resistance | R_{G} | | | | 1.1 | 1.4 | Ω |

^{5.} Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$.
6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

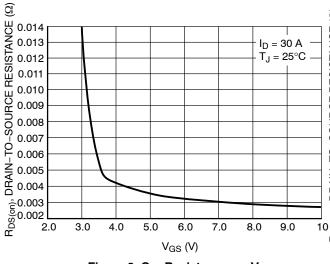


160 140 $V_{DS} = 10 V$ _D, DRAIN CURRENT (A) 120 100 80 $T_J = 25^{\circ}C$ 60 40 $T_J = 125^{\circ}$ 20 $T_J = -55^{\circ}C$ 0 1.0 1.5 2.0 2.5 3.0 3.5 4.0 V_{GS}, GATE-TO-SOURCE VOLTAGE (V)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics





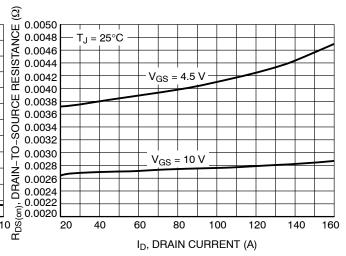
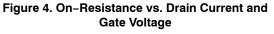
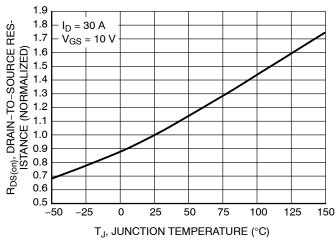


Figure 3. On-Resistance vs. V_{GS}





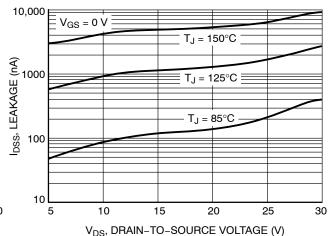


Figure 5. On-Resistance Variation with **Temperature**

Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

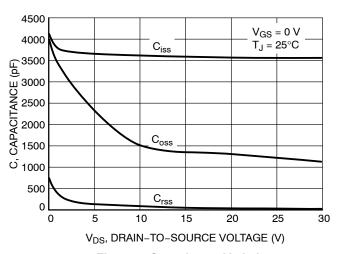


Figure 7. Capacitance Variation

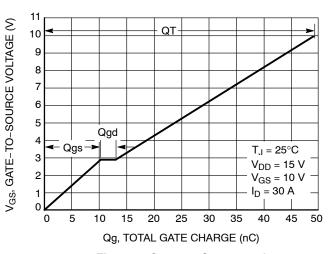


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

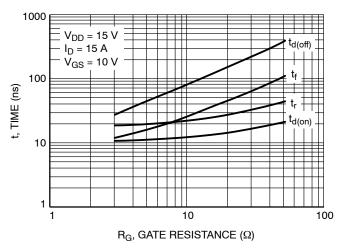


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

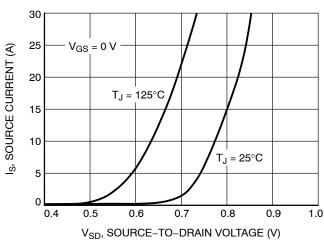


Figure 10. Diode Forward Voltage vs. Current

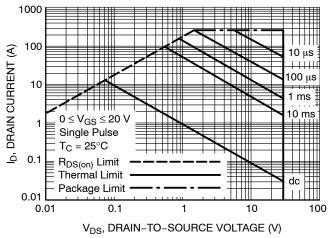


Figure 11. Maximum Rated Forward Biased Safe Operating Area

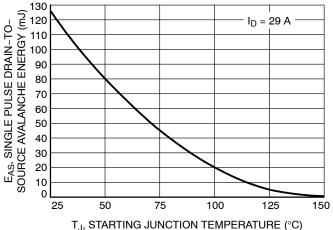


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

TYPICAL CHARACTERISTICS

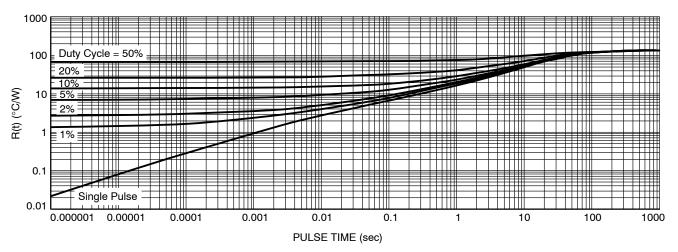


Figure 13. Thermal Response

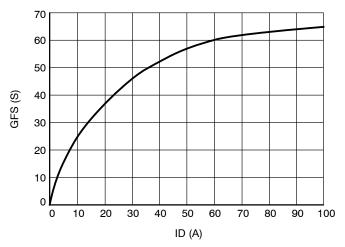


Figure 14. GFS vs. ID

SIDE VIEW



DFN5 5x6, 1.27P (SO-8FL) CASE 488AA ISSUE N

DATE 25 JUN 2018

NOTES:

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETER.
 DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS

| | MILLIMETERS | | | | |
|-----|-------------|----------|------|--|--|
| DIM | MIN | NOM | MAX | | |
| Α | 0.90 | 1.00 | 1.10 | | |
| A1 | 0.00 | | 0.05 | | |
| b | 0.33 | 0.41 | 0.51 | | |
| С | 0.23 | 0.28 | 0.33 | | |
| D | 5.00 | 5.15 | 5.30 | | |
| D1 | 4.70 | 4.90 | 5.10 | | |
| D2 | 3.80 | 4.00 | 4.20 | | |
| E | 6.00 | 6.15 | 6.30 | | |
| E1 | 5.70 | 5.90 | 6.10 | | |
| E2 | 3.45 | 3.65 | 3.85 | | |
| е | | 1.27 BSC | ; | | |
| G | 0.51 | 0.575 | 0.71 | | |
| K | 1.20 | 1.35 | 1.50 | | |
| L | 0.51 | 0.575 | 0.71 | | |
| L1 | 0.125 REF | | | | |
| M | 3.00 | 3.40 | 3.80 | | |
| A | n o | | 12 ° | | |

GENERIC MARKING DIAGRAM*



XXXXXX = Specific Device Code

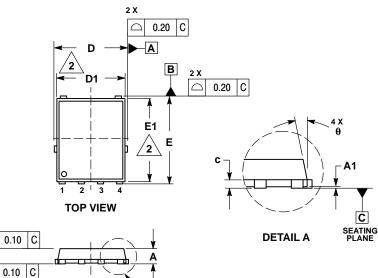
= Assembly Location Α

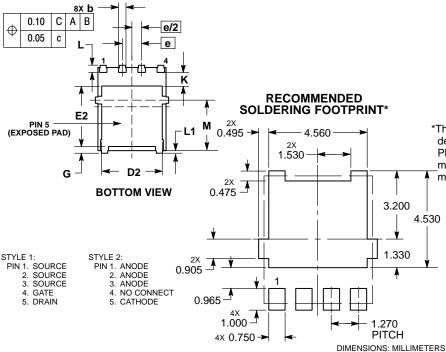
= Lot Traceability

Υ = Year W = Work Week

ZZ

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.





DETAIL A

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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|------------------|--------------------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-------------|--|
| DESCRIPTION: | DFN5 5x6, 1.27P (SO-8FL) | | PAGE 1 OF 1 | |

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